





IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : |

: Ryuta NAKANISHI et al.

Group Art Unit: Not Yet Assigned

Appl. No.

: 10/599,170 (U.S. National

Stage of PCT/JP2005/004676)

Examiner: Not Yet Assigned

I.A. Filed

: December 21, 2004

Confirmation No.: 5285

For

: CACHE MEMORY AND CONTROL METHOD THEREOF

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop <u>AMENDMENT</u>
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98, Applicants hereby bring to the attention of the Examiner the following information.

The following documents were cited in an International Search Report with respect to International Patent Application No. PCT/JP2005/004676, of which the above-captioned application is the U.S. National Stage Application. A copy of International Search Report has been filed concurrently with the filing of the above-captioned application, and should thus have already been brought to the attention of the Examiner.

P30744.A02

- (1) Japanese Laid-Open Patent Publication No. HEI 11-167520 A, together with an English language Abstract of the same, and patent family member U.S. Patent No. 6,173,392;
- (2) Japanese Laid-Open Patent Publication No. 2003-223360 A, together with an English language Abstract and an English language partial translation of the same;
- (3) Japanese Laid-Open Patent Publication No. HEI 7-084879 A, together with an English language Abstract of the same;
- (4) Japanese Laid-Open Patent Publication No. SHO 60-045855 A, together with an English language Abstract of the same;
- (5) Japanese Laid-Open Patent Publication No. SHO 61-016348 A, together with an English language Abstract of the same; and
- (6) Japanese Laid-Open Patent Publication No. SHO 51-019453 A, together with an English language translation of the same.

The relevance of the documents cited in the International Search Report, as ascertained with respect to the international claims by the International Examiner, is set forth in the International Search Report.

Applicants further bring to the attention of the Examiner the following documents:

(7) Japanese Laid-Open Patent Publication No. HEI 7-295882 A, together with an English language Abstract of the same. Applicants note that this document is cited on page 1 of the specification of the above-captioned application;

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- (8) U.S. Patent Publication No.10/571,531 to TANAKA et al., which was filed on March 10, 2006;
- (9) U.S. Patent Publication No.10/577,133 to OKABAYASHI et al., which was filed on April 10, 2006;
- (10) U.S. Patent Publication No.10/578,314 to TANAKA et al., which was filed on May 4, 2006;
- (11) U.S. Patent Publication No.10/578,299 to OKABAYASHI et al., which was filed on May 4, 2006; and
- (12) U.S. Patent Publication No.10/583,773 to NAKANISHI et al., which was filed on June 21, 2006.

Further to 37 C.F.R. §1.98 (a)(2)(ii) and the U.S. Patent and Trademark Office's decision to waive the requirement under 37 C.F.R. §1.98 (a)(2)(iii) if the U.S. patent application was filed after June 30, 2003, copies of the U.S. patent publication and patent applications are not enclosed herewith. However, if any copy is needed, the Examiner is respectfully requested to contact the undersigned.

Also, when the above-noted pending applications are published, the Examiner is respectfully requested to list their publication numbers on a PTO 1449 Form (or PTO 892 Form) to confirm consideration thereof.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto, and all of the documents are listed on an attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of

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the completed Form to Applicants with the next official communication in the present application.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted, Ryuta NAKANISHI et al.

Bruce H. Bernste

Reg. No. 29,027

William Pieprz Reg. No. 33630

December 21, 2006 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, Virginia 20191 (703) 716-1191 FORM PTO-1449

.S. Department of Commerce Patent and Trademark Office Atty. Docket P30744

Application No. 10/599,170

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BY APPLICANT
(Use several sheets if necessary)

Applicant
Ryuta NAKANISHI et al.

Filing Date
December 21, 20

Group

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	1	En	glish	Lar	ngua	ge A	bstr	act o	f JP 11-1675	20.							
	2	English Language Abstract of JP 2003-223360.															
	3	En	glish	Lar	igua	ge A	bstr	act o	f JP 60-0458	55.							
	4	En	glish	Lar	ıgua	ge A	bstr	act o	f JP 61-0163	48.						**	
	5	En	glish	Lar	igua	ge A	bstr	act o	f JP 7-29588	2.							
	6	En	glish	Lar	igua	ge A	bstr	act o	f JP 7-08487	9.							

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered.

Include copy of this form with next communication to applicant.